

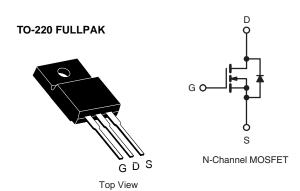
IXTP12N50PM-VB Datasheet

N-Channel 550V (D-S) Power MOSFET

PRODUCT SUMM	ARY	
V _{DS} (V)	55	0
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V	0.26
Q _g max. (nC)	150	0
Q _{gs} (nC)	12	2
Q _{gd} (nC)	25	5
Configuration	Sing	gle

FEATURES

- Optimal Design
 - Low Area Specific On-Resistance
 - Low Input Capacitance (Ciss)
 - Reduced Capacitive Switching Losses
 - High Body Diode Ruggedness
 - Avalanche Energy Rated (UIS)
- Optimal Efficiency and Operation
 - Low Cost
 - Simple Gate Drive Circuitry
 - Low Figure-of-Merit (FOM): Ron x Qa
 - Fast Switching



APPLICATIONS

- Consumer Electronics
 Displays (LCD or Plasma T
 - Displays (LCD or Plasma TV)
- Server and Telecom Power Supplies
 SMPS
- Industrial
 - Welding
 - Induction Heating
 - Motor Drives
- Battery Chargers
- SMPS
 - Power Factor Correction (PFC)

ABSOLUTE MAXIMUM RATINGS (T_C					1
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	550	
Gate-Source Voltage		V	± 20	V	
Gate-Source Voltage AC (f > 1 Hz)			V _{GS}	30	
Continuous Drain Current (T _{.1} = 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$,	18	
Continuous Drain Current (1) = 150 C)	VGS at 10 V	T _C = 100 °C	l _D	11	Α
Pulsed Drain Current ^a			I _{DM}	56	
Linear Derating Factor				2.2	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	281	mJ
Maximum Power Dissipation			P_{D}	60	W
Operating Junction and Storage Temperature Range	е		T _J , T _{stg}	- 55 to + 150	°C
Drain-Source Voltage Slope	$T_J = 1$	25 °C	47.1/4+	24	1//20
Reverse Diode dV/dt ^d		dV/dt	0.36	V/ns	
Soldering Recommendations (Peak Temperature)	for 1	0 s		300°	°C

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 10 mH, R_g = 25 Ω , I_{AS} = 7.5 A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, starting $T_J = 25$ °C.

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THERMAL RESISTANCE RATI	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.45	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•			•	•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	550	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 250 μA	-	0.56	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2	-	4	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} =	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	μΑ
Zelo Gate Voltage Dialii Current	I _{DSS}	$V_{DS} = 400 \text{ V}$	V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		-	10	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V}$	$I_D = 10 \text{ A}$	-	0.26	-	Ω
Forward Transconductance	9 _{fs}	V_{DS}	$= 50 \text{ V}, I_D = 10 \text{ A}$	ı	12	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ $f = 1 \text{ MHz}$		-	3094	-	pF
Output Capacitance	C _{oss}			-	152	-	
Reverse Transfer Capacitance	C_{rss}			-	13	-	
Effective output capacitance, energy related ^a	$C_{\text{o(er)}}$	V _{GS} = 0 V, V _{DS} = 0 V to 400 V		-	131	-	
Effective output capacitance, time related ^b	$C_{o(tr)}$			-	189	-	
Total Gate Charge	Q _g			-	80	150	
Gate-Source Charge	Q_{gs}	$V_{GS} = 10 \text{ V}$ $I_{D} = 10 \text{ A}, V_{DS} = 400 \text{ V}$		-	12	-	nC
Gate-Drain Charge	Q_{gd}			-	25	-	
Turn-On Delay Time	t _{d(on)}			-	24	50	
Rise Time	t _r	$V_{DD} = 400 \text{ V}, I_D = 10 \text{ A}, V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$		-	31	62	- ns
Turn-Off Delay Time	t _{d(off)}			-	117	176	
Fall Time	t _f			-	56	112	
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	1.8	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	
Pulsed Diode Forward Current	I _{SM}			-	-	80	A
Diode Forward Voltage	V _{SD}	$T_{J} = 25 ^{\circ}\text{C}, I_{S} = 10 \text{A}, V_{GS} = 0 \text{V}$		-	-	1.2	V
Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 10 \text{ A},$ $dI/dt = 100 \text{ A/µs}, V_R = 20 \text{ V}$		-	437	-	ns
Reverse Recovery Charge	Q _{rr}			-	5.9	-	μC
Reverse Recovery Current	I _{RRM}			-	25	-	A

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

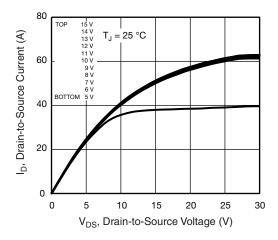


Fig. 1 - Typical Output Characteristics

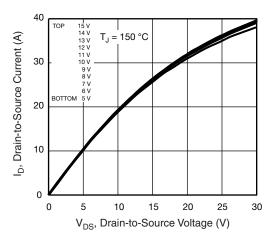


Fig. 2 - Typical Output Characteristics

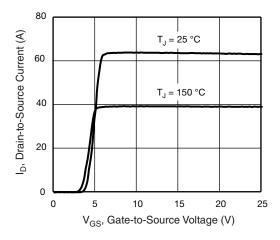


Fig. 3 - Typical Transfer Characteristics

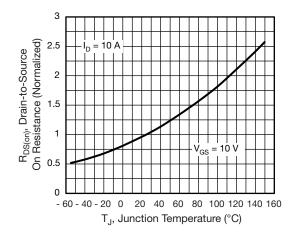


Fig. 4 - Normalized On-Resistance vs. Temperature

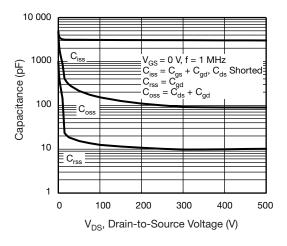


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

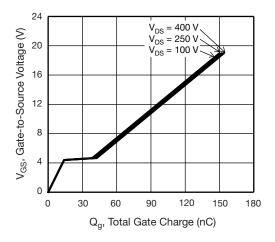


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



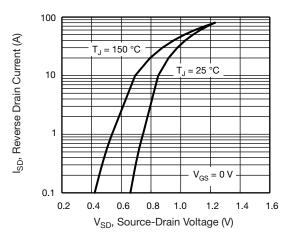


Fig. 7 - Typical Source-Drain Diode Forward Voltage

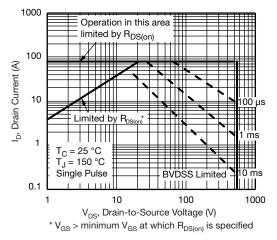


Fig. 8 - Maximum Safe Operating Area

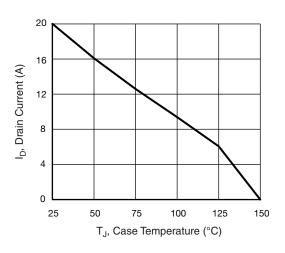


Fig. 9 - Maximum Drain Current vs. Case Temperature

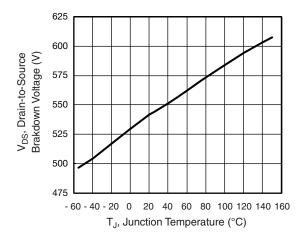


Fig. 10 - Temperature vs. Drain-to-Source Voltage

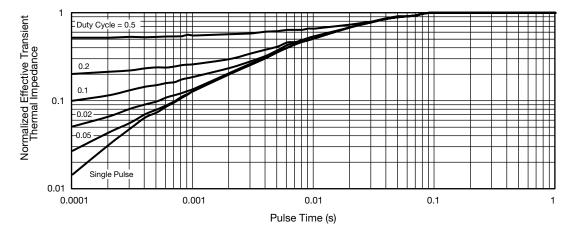


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



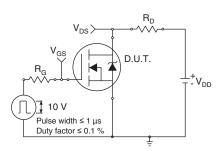


Fig. 12 - Switching Time Test Circuit

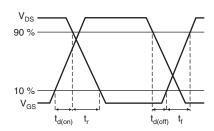


Fig. 13 - Switching Time Waveforms

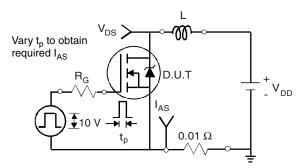


Fig. 14 - Unclamped Inductive Test Circuit

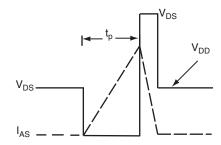


Fig. 15 - Unclamped Inductive Waveforms

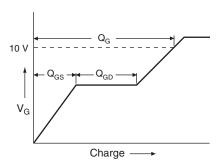


Fig. 16 - Basic Gate Charge Waveform

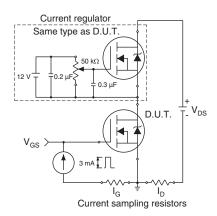
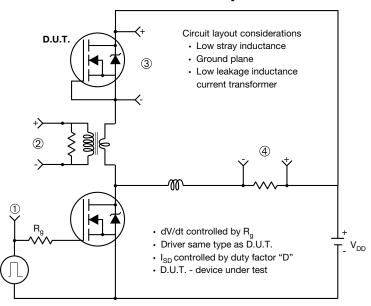


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



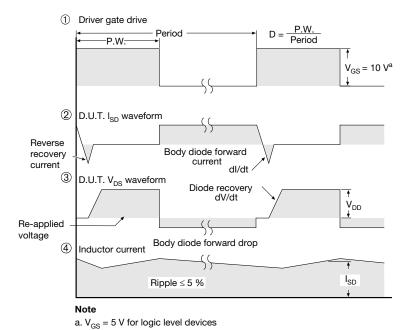
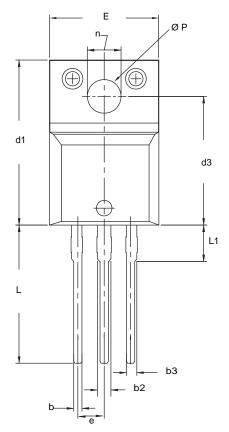
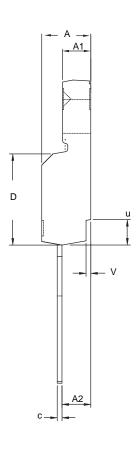


Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)





DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØΡ	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

ECN: X09-0126-Rev. B, 26-Oct-09 DWG: 5972

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
- 4. All dimensions include burrs and plating thickness.
- 5. No chipping or package damage.



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